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		3	9	3	7	5	7	9	02/10/76	Schmidt		356	144	11/15/73		
		4	1	8	9	8	2	0	02/26/80	Slack		29	425	02/21/78		
		4	2	6	1	7	8	1	04/14/81	Edmonds et al.		156	254	01/31/7		
		4	7	8	2	0	2	8	11/01/88	Farrier et al.		437	3	08/27/87		
		5	1	4	2	7	5	6	09/01/92	Ibaraki et al.		29	25.01	10/19/90		
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		5	5	3	0	5	5	2	06/25/96	Mermagen et al.		356	401	12/28/94		
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